

DATA SHEET

BF545A; BF545B; BF545C N-channel silicon junction field-effect transistors

Product specification
Supersedes data of April 1995
File under Discrete Semiconductors, SC07

1996 Jul 29

N-channel silicon junction field-effect transistors

BF545A; BF545B; BF545C

FEATURES

- Low leakage level (typ. 500 fA)
- High gain
- Low cut-off voltage (max. 2.2 V for BF545A).

APPLICATIONS

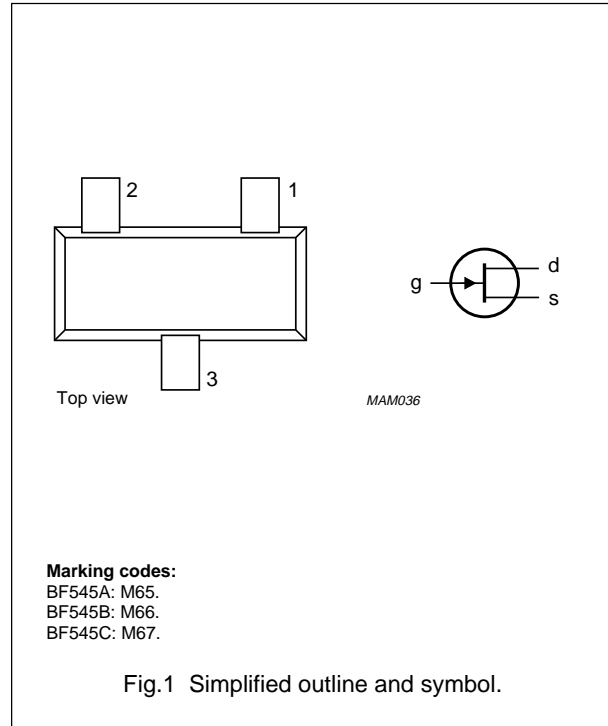
- Impedance converters in e.g. electret microphones and infra-red detectors
- VHF amplifiers in oscillators and mixers.

DESCRIPTION

N-channel symmetrical silicon junction field-effect transistors in a SOT23 package.

PINNING - SOT23

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | s | source |
| 2 | d | drain |
| 3 | g | gate |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-------------|-----------------------------|---|------|----------|------|
| V_{DS} | drain-source voltage | | – | ± 30 | V |
| V_{GSoff} | gate-source cut-off voltage | $I_D = 1 \mu A$; $V_{DS} = 15 V$ | –0.4 | –7.8 | V |
| I_{DSS} | drain current | $V_{GS} = 0$; $V_{DS} = 15 V$ | | | |
| | BF545A | | 2 | 6.5 | mA |
| | BF545B | | 6 | 15 | mA |
| | BF545C | | 12 | 25 | mA |
| P_{tot} | total power dissipation | up to $T_{amb} = 25 \text{ }^\circ\text{C}$ | – | 250 | mW |
| $ y_{fs} $ | forward transfer admittance | $V_{GS} = 0$; $V_{DS} = 15 V$ | 3 | 6.5 | mS |

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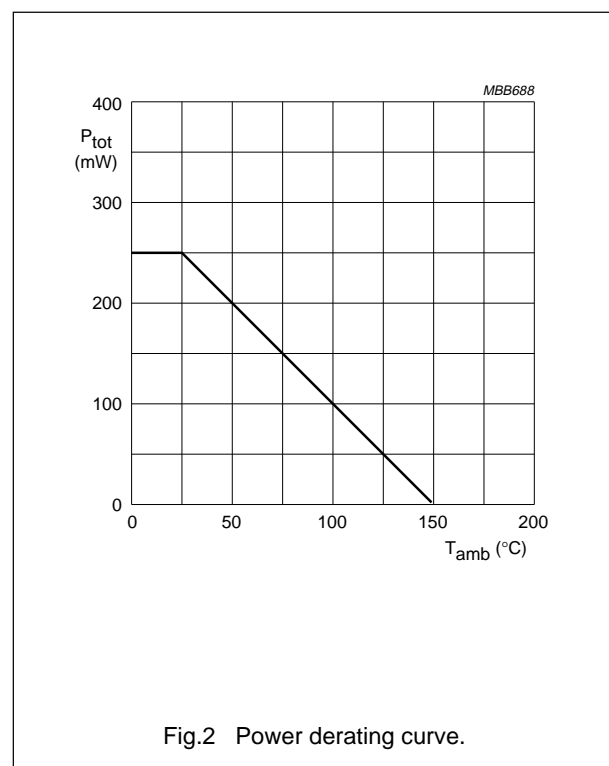
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|---|------|----------|------|
| V_{DS} | drain-source voltage | | – | ± 30 | V |
| V_{GSO} | gate-source voltage | open drain | – | –30 | V |
| V_{GDO} | gate-drain voltage (DC) | open source | – | –30 | V |
| I_G | forward gate current (DC) | | – | 10 | mA |
| P_{tot} | total power dissipation | up to $T_{amb} = 25\text{ °C}$; note 1 | – | 250 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | operating junction temperature | | – | 150 | °C |

Note

1. Device mounted on an FR4 printed-circuit board, maximum lead length 4 mm; mounting pad for the drain lead 10 mm².



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THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-a}$ | thermal resistance from junction to ambient; note 1 | 500 | K/W |

Note

1. Device mounted on an FR4 printed-circuit board, maximum lead length 4 mm; mounting pad for the drain lead 10 mm².

STATIC CHARACTERISTICS

$T_j = 25\text{ °C}$; unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---|--|------|------|-------|---------------|
| $V_{(BR)GSS}$ | gate-source breakdown voltage | $I_G = -1\ \mu\text{A}$; $V_{DS} = 0$ | -30 | - | - | V |
| V_{GSoff} | gate-source cut-off voltage BF545A BF545B BF545C | $I_D = 200\ \mu\text{A}$; $V_{DS} = 15\ \text{V}$ | -0.4 | - | -2.2 | V |
| | | | -1.6 | - | -3.8 | V |
| | | | -3.2 | - | -7.8 | V |
| | | $I_D = 1\ \mu\text{A}$; $V_{DS} = 15\ \text{V}$ | -0.4 | - | -7.5 | V |
| I_{DSS} | drain current BF545A BF545B BF545C | $V_{GS} = 0$; $V_{DS} = 15\ \text{V}$ | 2 | - | 6.5 | mA |
| | | | 6 | - | 15 | mA |
| | | | 12 | - | 25 | mA |
| I_{GSS} | gate leakage current | $V_{GS} = -20\ \text{V}$; $V_{DS} = 0$ | - | -0.5 | -1000 | pA |
| | | $V_{GS} = -20\ \text{V}$; $V_{DS} = 0$; $T_j = 125\text{ °C}$ | - | - | -100 | nA |
| $ y_{fs} $ | forward transfer admittance | $V_{GS} = 0$; $V_{DS} = 15\ \text{V}$ | 3 | - | 6.5 | mS |
| $ y_{os} $ | common source output admittance | $V_{GS} = 0$; $V_{DS} = 15\ \text{V}$ | - | 40 | - | μS |

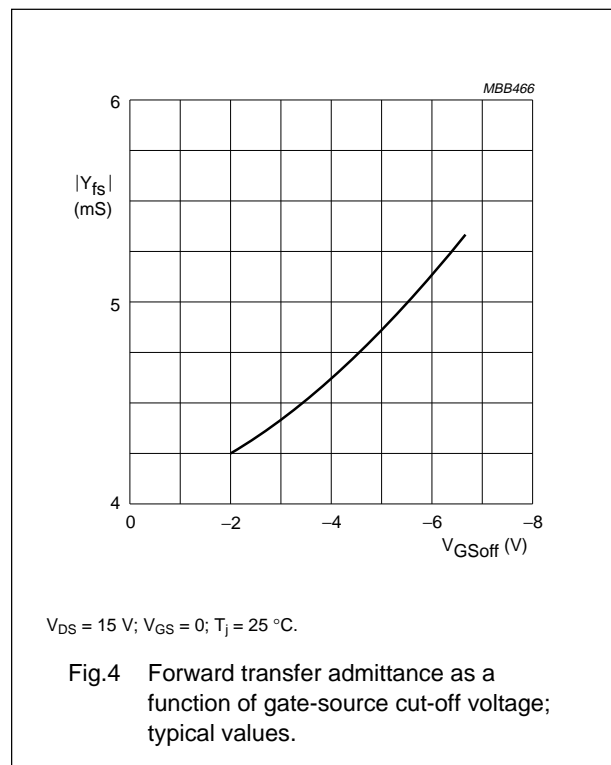
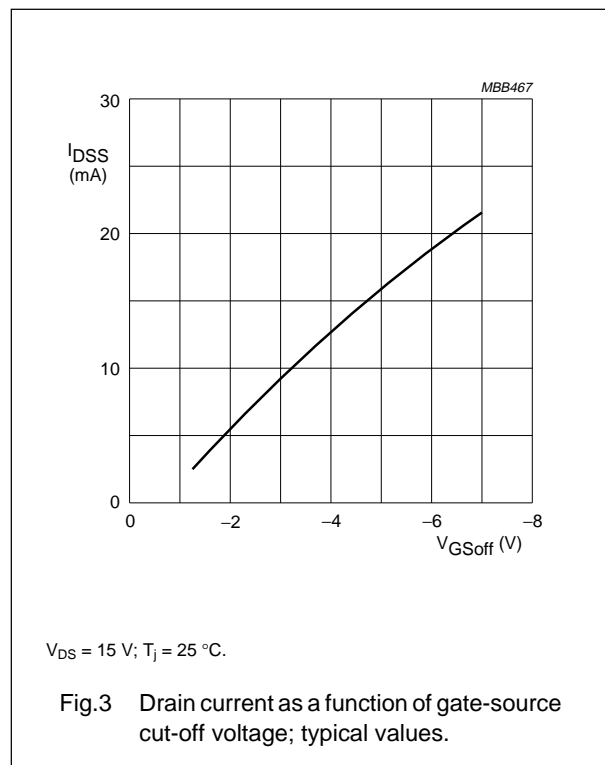
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DYNAMIC CHARACTERISTICS

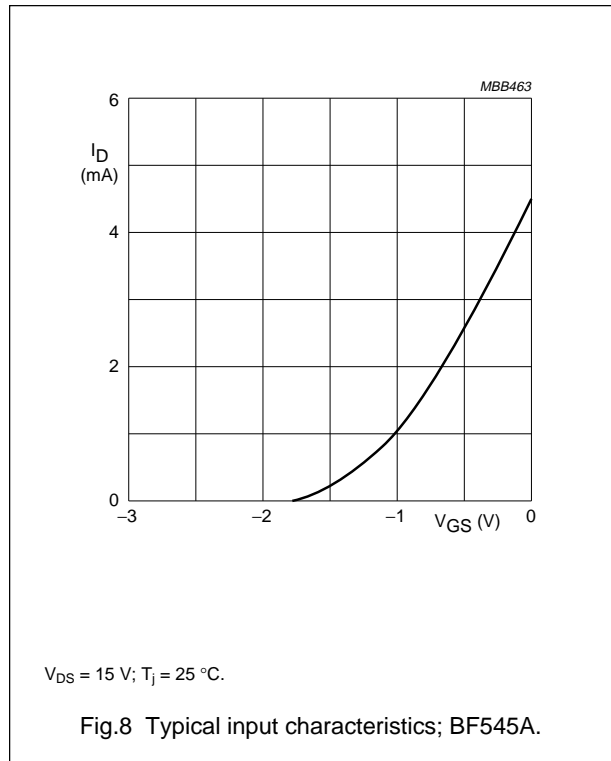
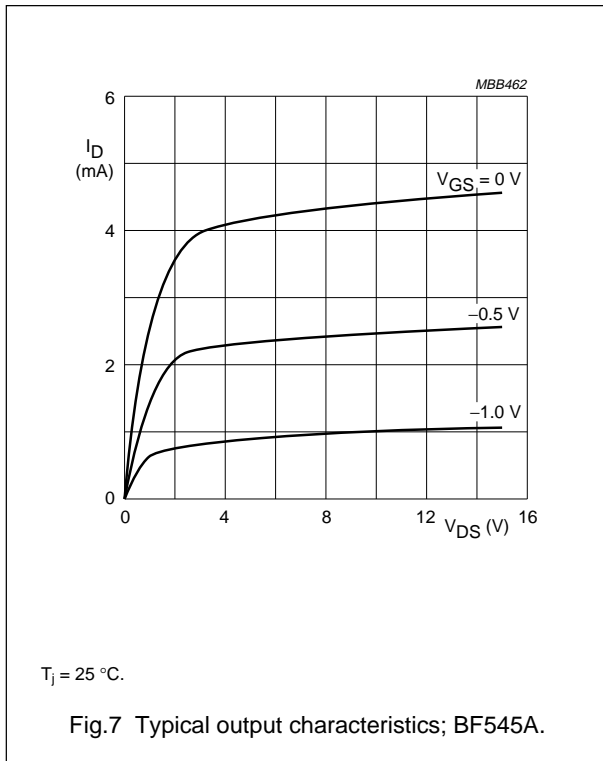
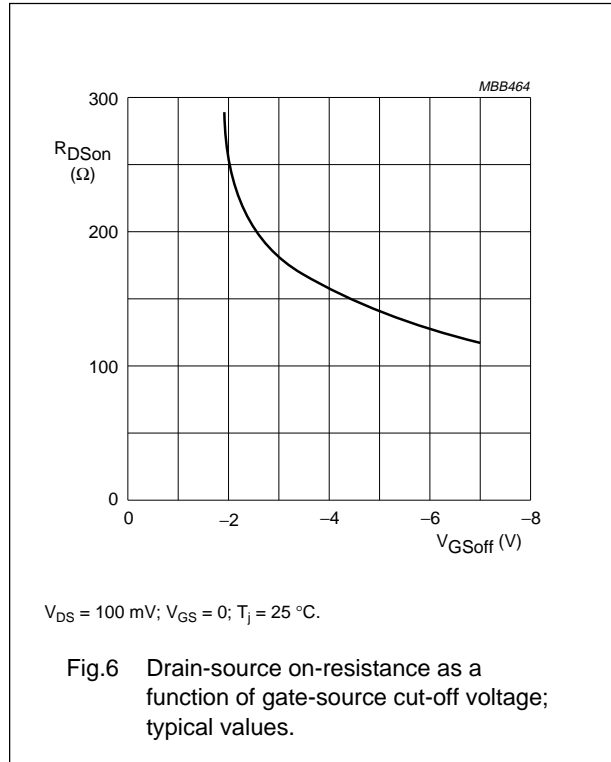
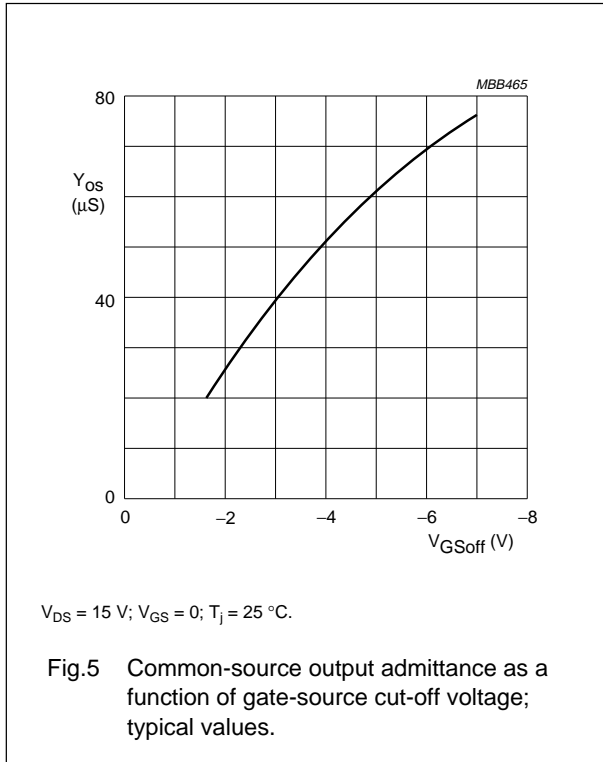
$T_{amb} = 25\text{ }^{\circ}\text{C}$; unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | TYP. | UNIT |
|----------|------------------------------------|---|------|---------------|
| C_{is} | input capacitance | $V_{DS} = 15\text{ V}; V_{GS} = -10\text{ V}; f = 1\text{ MHz}$ | 1.7 | pF |
| | | $V_{DS} = 15\text{ V}; V_{GS} = 0; f = 1\text{ MHz}$ | 3 | pF |
| C_{rs} | reverse transfer capacitance | $V_{DS} = 15\text{ V}; V_{GS} = -10\text{ V}; f = 1\text{ MHz}$ | 0.8 | pF |
| | | $V_{DS} = 15\text{ V}; V_{GS} = 0; f = 1\text{ MHz}$ | 0.9 | pF |
| g_{is} | common source input conductance | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 100\text{ MHz}$ | 15 | μS |
| | | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 450\text{ MHz}$ | 300 | μS |
| g_{fs} | common source transfer conductance | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 100\text{ MHz}$ | 2 | mS |
| | | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 450\text{ MHz}$ | 1.8 | mS |
| g_{rs} | common source reverse conductance | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 100\text{ MHz}$ | -6 | μS |
| | | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 450\text{ MHz}$ | -40 | μS |
| g_{os} | common source output conductance | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 100\text{ MHz}$ | 30 | μS |
| | | $V_{DS} = 10\text{ V}; I_D = 1\text{ mA}; f = 450\text{ MHz}$ | 60 | μS |



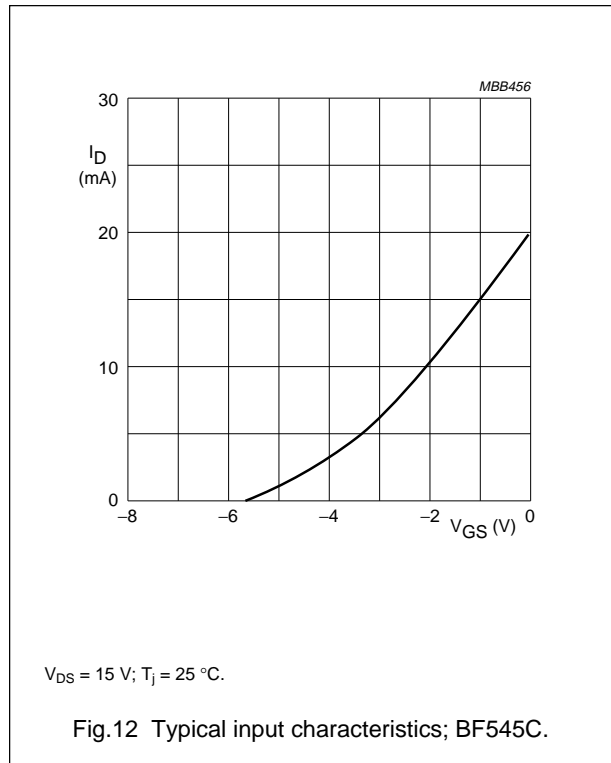
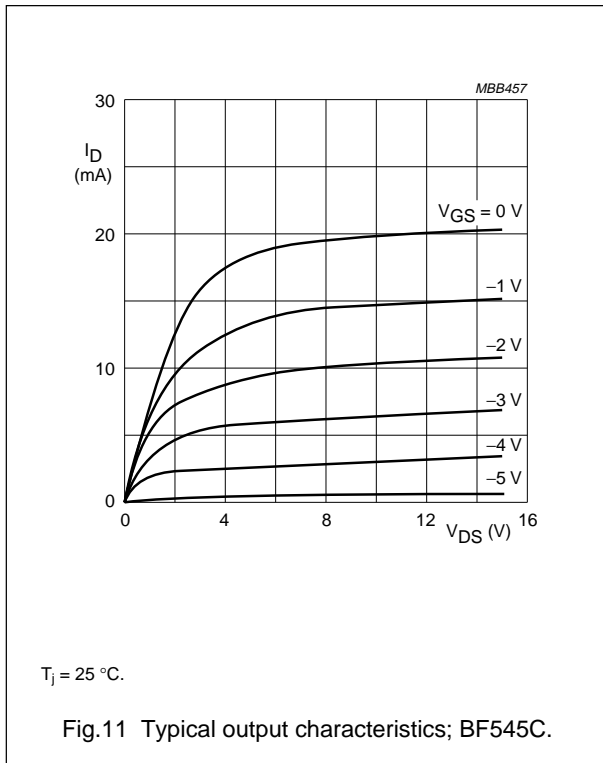
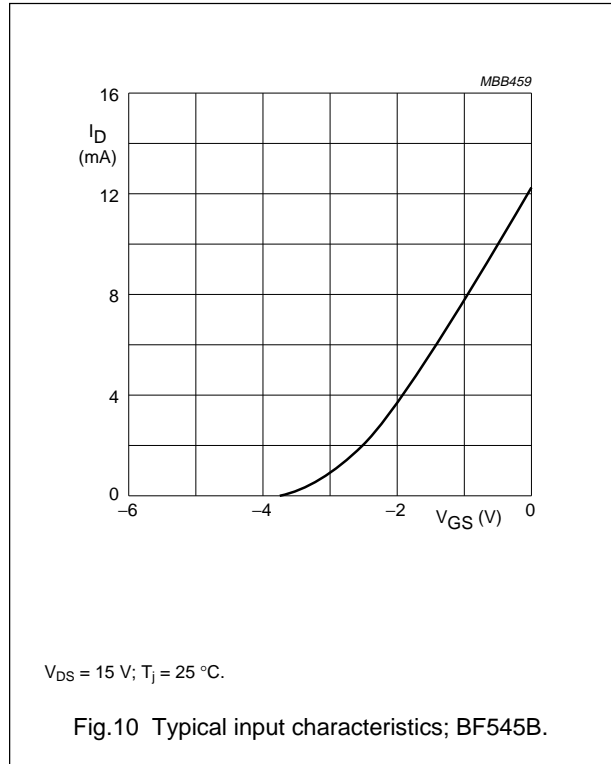
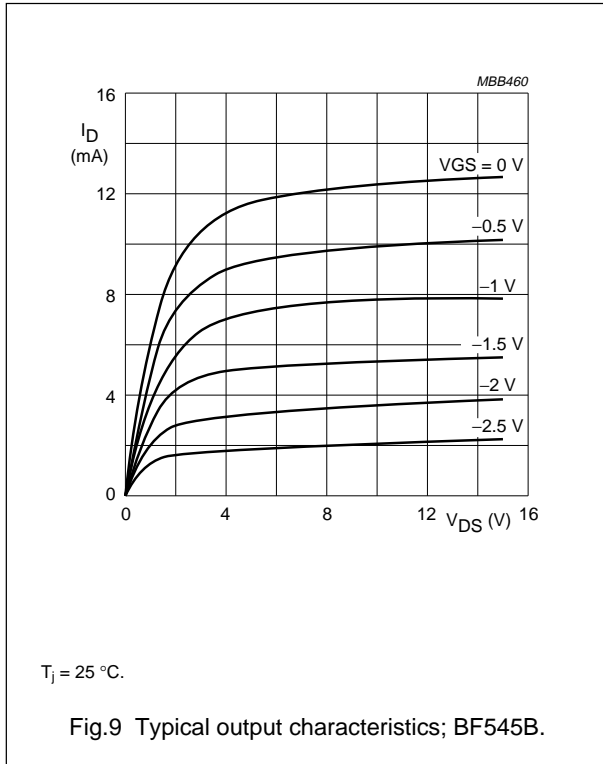
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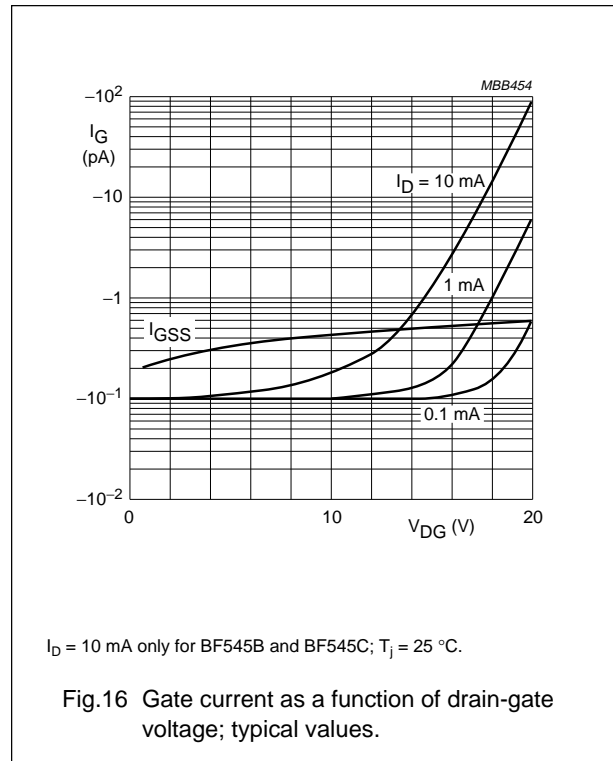
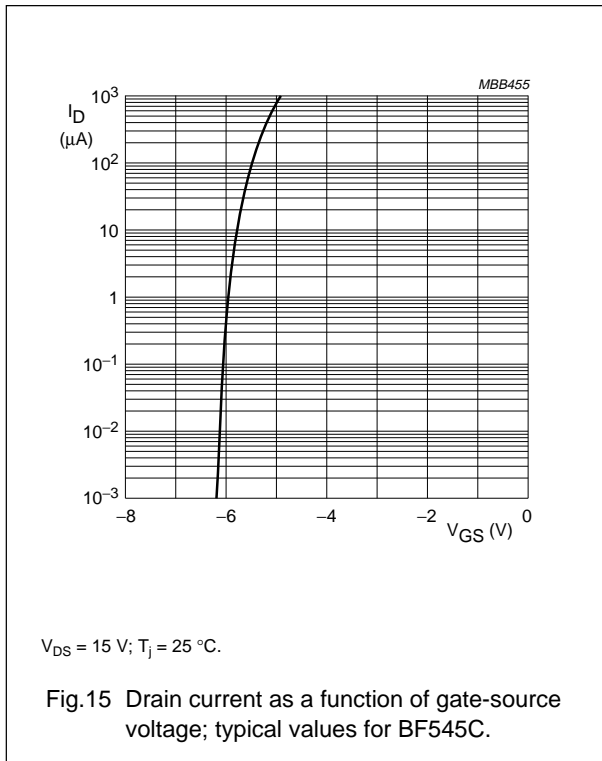
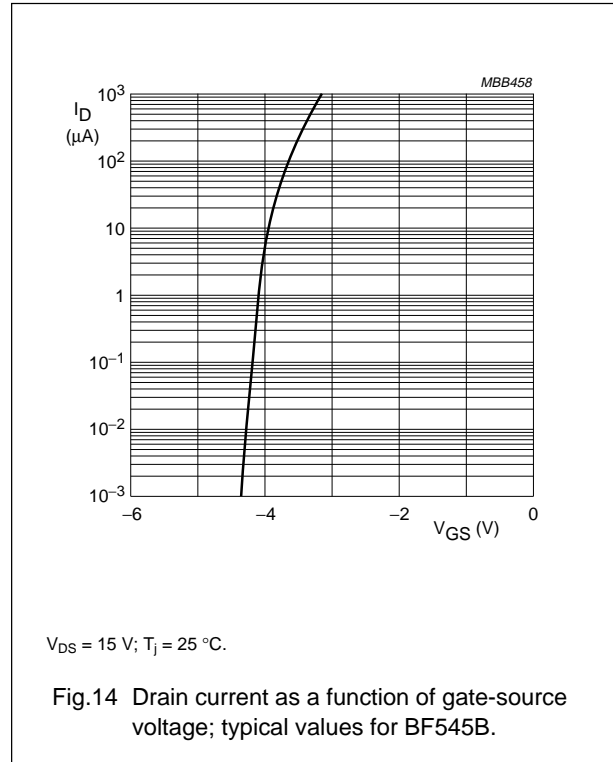
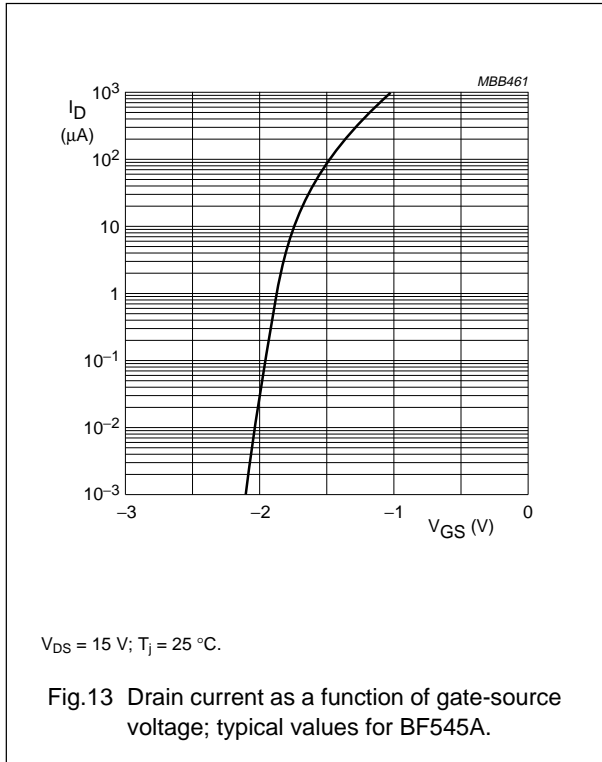
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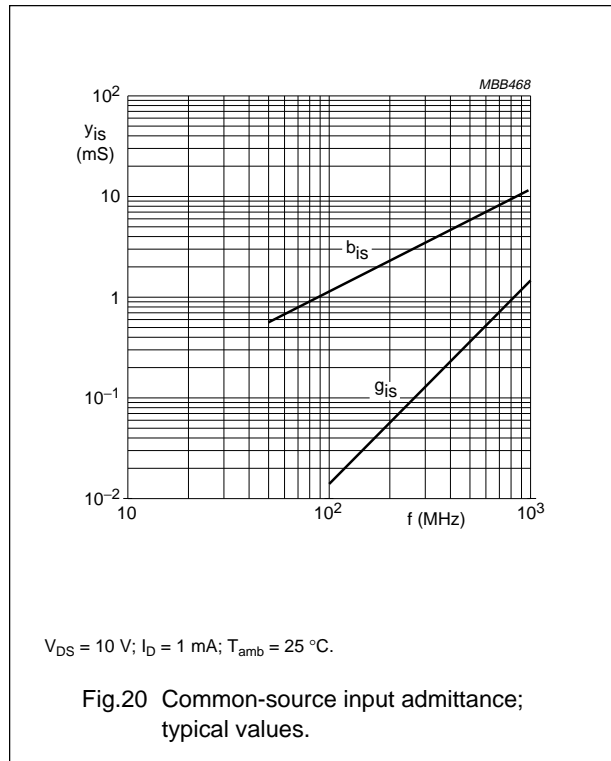
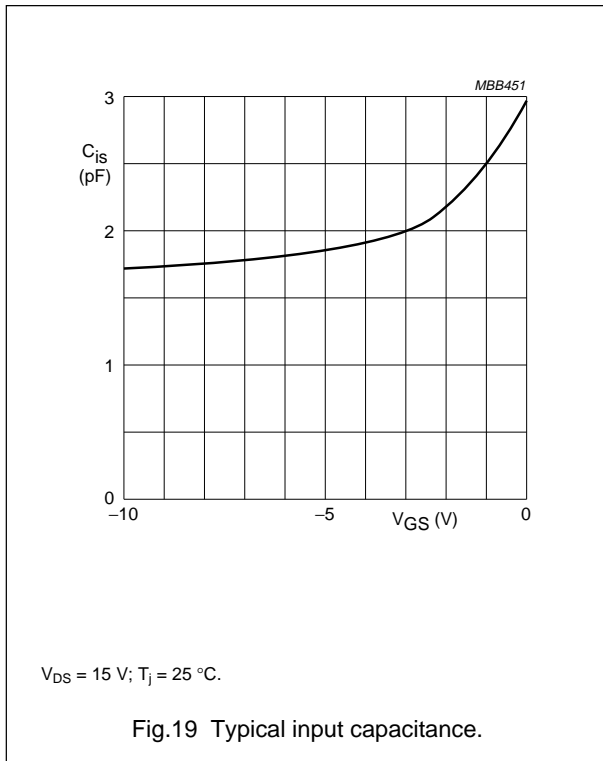
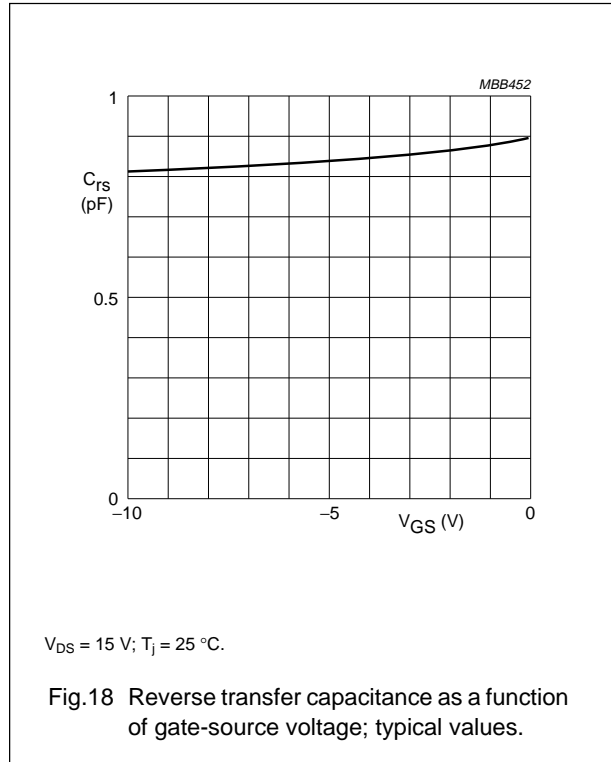
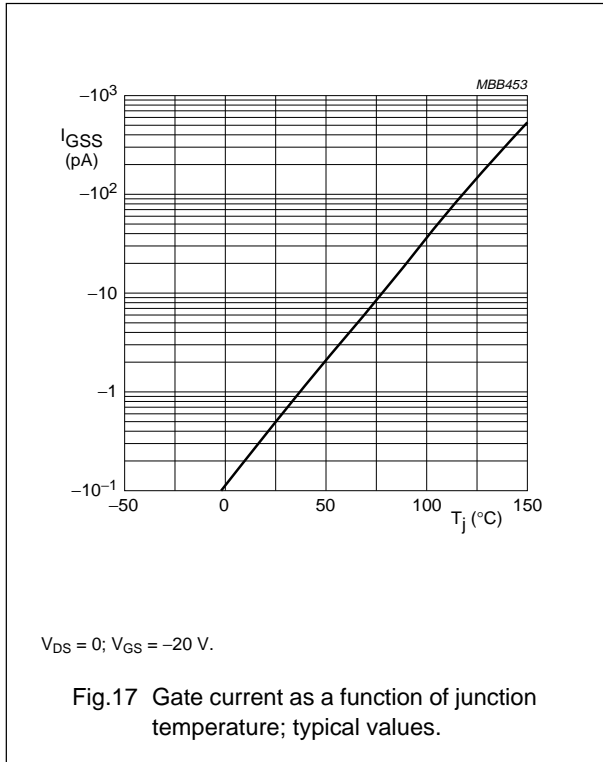
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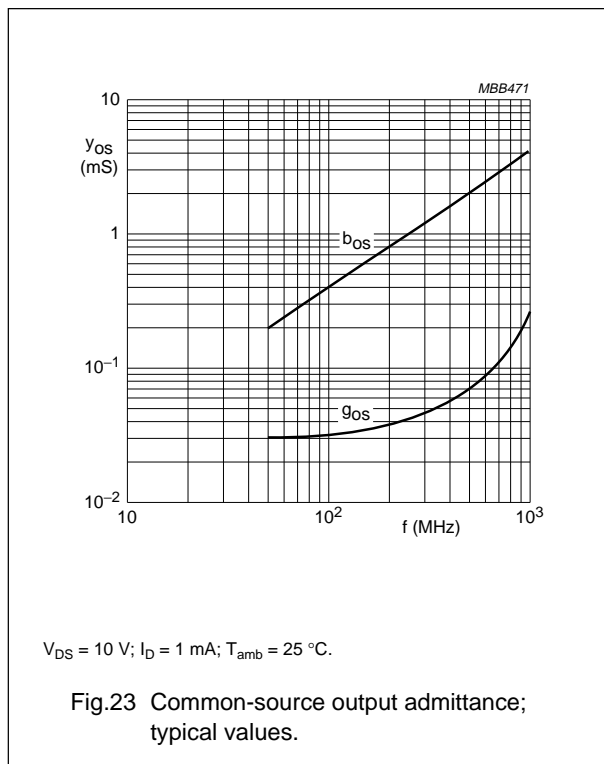
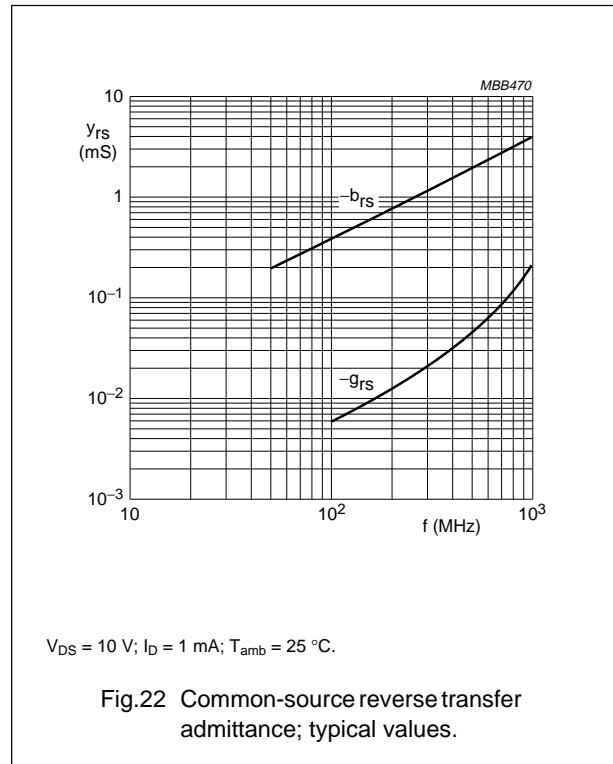
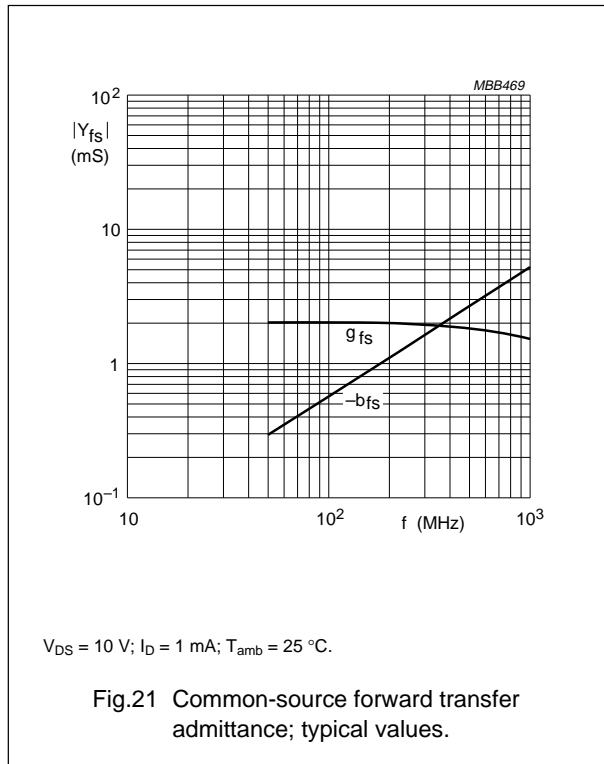
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DEFINITIONS

| Data Sheet Status | |
|---|---|
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | |
| Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | |
| Application information | |
| Where application information is given, it is advisory and does not form part of the specification. | |

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